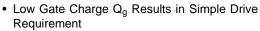


Power MOSFET

PRODUCT SUMM	ARY	
V _{DS} (V)	650)
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	2.1
Q _g (Max.) (nC)	48	1
Q _{gs} (nC)	12	
Q _{gd} (nC)	19	1
Configuration	Sing	le

FEATURES

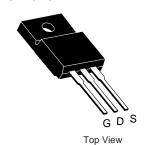


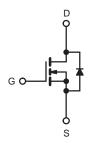


• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V _{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 30	7 v	
Continuous Drain Currente	\/ ot 10 \/	T _C = 25 °C	-	4.5		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	- I _D	4.2	Α	
Pulsed Drain Current ^a			I _{DM}	18		
Linear Derating Factor				0.48	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	325	mJ	
Repetitive Avalanche Current ^a			I _{AR}	4	Α	
Repetitive Avalanche Energy ^a			E _{AR}	6	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D	30	W	
Peak Diode Recovery dV/dtc			dV/dt	2.8	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) ^d	for 10 s		-	300	7	
Manuatina Taurus	6 22 or I	M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 01 1	NIO SCIEW		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T $_J$ = 25 °C, L = 24 mH, R $_G$ = 25 Ω , I $_{AS}$ = 3.2 A (see fig. 12). c. I $_{SD}$ ≤ 3.2 A, dI/dt ≤ 90 A/ μ s, V $_{DD}$ ≤ V $_{DS}$, T $_J$ ≤ 150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



THERMAL RESISTANCE RA	TINGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.1	C/VV

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I _D = 1 mA ^d		670	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$		-	25 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.1 A ^b	-	-	2.1	Ω
Forward Transconductance	9 _{fs}		= 50 V, I _D = 3.1 A	3.9	-	-	S
Dynamic	<u> </u>						
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1417	-	
Output Capacitance	C _{oss}		V _{DS} = 25 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		177	-	- - -
Reverse Transfer Capacitance	C _{rss}	f = 1			7.0	-	
Dutnut Consideres	C _{oss}		V _{DS} = 1.0 V, f = 1.0 MHz	-	1912	-	- pF
Output Capacitance		V _{GS} = 0 V	V _{DS} = 520 V, f = 1.0 MHz	-	48	-	
Effective Output Capacitance	Coss eff.		V _{DS} = 0 V to 520 V ^c	- 84	-	1	
Total Gate Charge	Qg		= 10 V $I_D = 3.2 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 ^b	-	-	48	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V		-	-	12	
Gate-Drain Charge	Q _{gd}			-	-	19	
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r		$V_{DD} = 325 \text{ V}, I_D = 3.2 \text{ A}$		20	-	ns
Turn-Off Delay Time	t _{d(off)}	$R_G = 9.1 \Omega, R_D = 62 \Omega,$ see fig. 10^b		-	34	-	
Fall Time	t _f				18	-	
Drain-Source Body Diode Characteristic	s				•		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		ı	-	4	A
Pulsed Diode Forward Current ^a	I _{SM}		integral reverse p - n junction diode		-	21	
Body Diode Voltage	V_{SD}	T _J = 25 °C	$T_J = 25 ^{\circ}\text{C}, I_S = 3.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.2 A, dl/dt = 100 A/μs ^b			493	739	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.1	3.2	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is don	ninated by	L _S and I	L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} . d. t = 60 s, f = 60 Hz.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

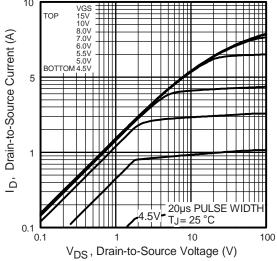


Fig. 1 - Typical Output Characteristics

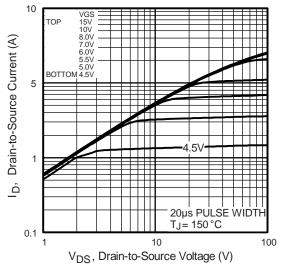


Fig. 2 - Typical Output Characteristics

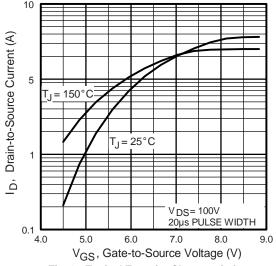


Fig. 3 - Typical Transfer Characteristics

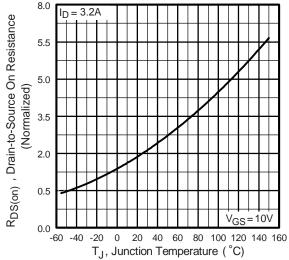


Fig. 4 - Normalized On-Resistance vs. Temperature



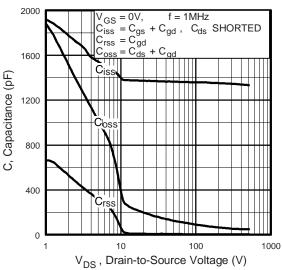


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

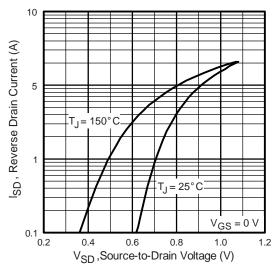


Fig. 7 - Typical Source-Drain Diode Forward Voltage

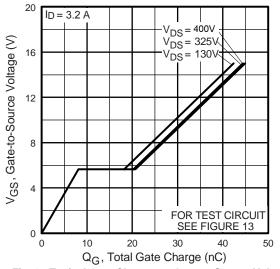


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

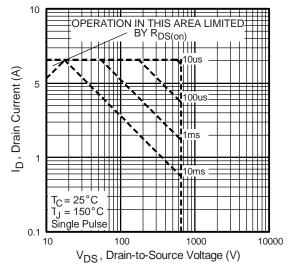


Fig. 8 - Maximum Safe Operating Area



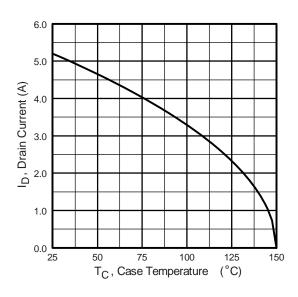


Fig. 9 - Maximum Drain Current vs. Case Temperature

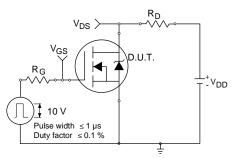


Fig. 10a - Switching Time Test Circuit

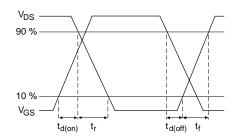


Fig. 10b - Switching Time Waveforms

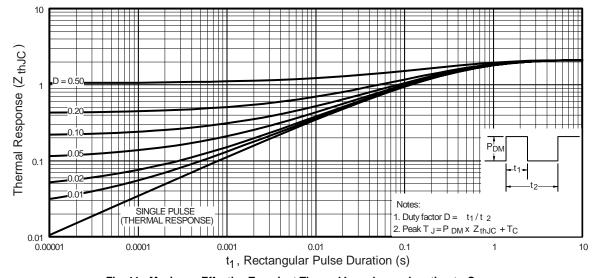


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

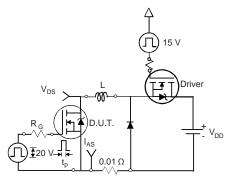


Fig. 12a - Unclamped Inductive Test Circuit

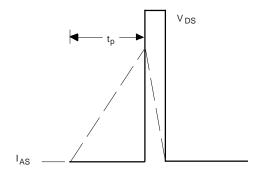


Fig. 12b - Unclamped Inductive Waveforms



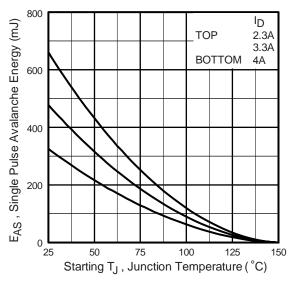


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

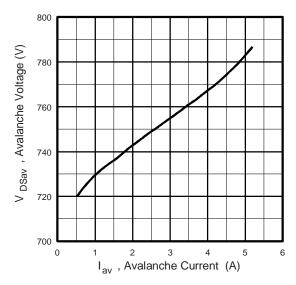


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

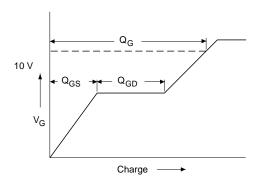


Fig. 13a - Basic Gate Charge Waveform

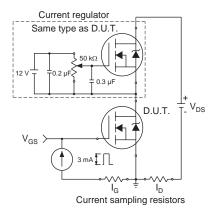
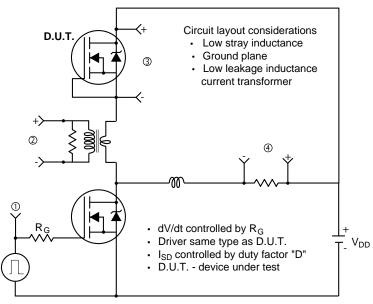
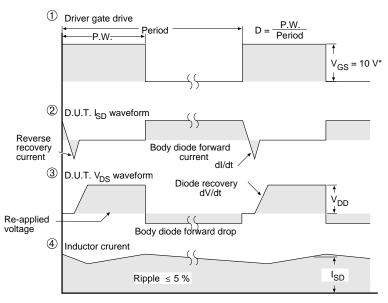


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



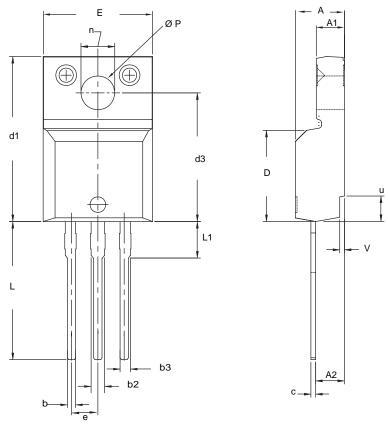


* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



MIN. 4.570 2.570 2.510 0.622 1.229 1.229 0.440	MAX. 4.830 2.830 2.850 0.890 1.400 1.400	MIN. 0.180 0.101 0.099 0.024 0.048	MAX. 0.190 0.111 0.112 0.035 0.055
2.570 2.510 0.622 1.229 1.229	2.830 2.850 0.890 1.400	0.101 0.099 0.024	0.111 0.112 0.035
2.510 0.622 1.229 1.229	2.850 0.890 1.400	0.099 0.024	0.112 0.035
0.622 1.229 1.229	0.890 1.400	0.024	0.035
1.229 1.229	1.400		
1.229		0.048	0.055
	1 400		0.000
0.440	1.700	0.048	0.055
0.110	0.629	0.017	0.025
8.650	9.800	0.341	0.386
15.88	16.120	0.622	0.635
12.300	12.920	0.484	0.509
10.360	10.630	0.408	0.419
2.54	BSC	0.100	BSC
13.200	13.730	0.520	0.541
3.100	3.500	0.122	0.138
6.050	6.150	0.238	0.242
3.050	3.450	0.120	0.136
2.400	2.500	0.094	0.098
0.400	0.500	0.016	0.020
	12.300 10.360 2.54 13.200 3.100 6.050 3.050 2.400	12.300 12.920 10.360 10.630 2.54 BSC 13.200 13.730 3.100 3.500 6.050 6.150 3.050 3.450 2.400 2.500 0.400 0.500	12.300 12.920 0.484 10.360 10.630 0.408 2.54 BSC 0.100 13.200 13.730 0.520 3.100 3.500 0.122 6.050 6.150 0.238 3.050 3.450 0.120 2.400 2.500 0.094 0.400 0.500 0.016

Notes

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
 All dimensions include burrs and plating thickness.

- 5. No chipping or package damage.



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